

<b>Notice of References Cited</b>	Application/Control No. 10/534,421		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Paul Marcantoni		Art Unit 1793	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,506,248	01-2003	Duselis et al.	106/713
*	B	US-6,346,146	02-2002	Duselis et al.	106/713
*	C	US-3,352,746	11-1967	WILLIAMS STANLEY E et al.	162/153
*	D	US-1,932,971	10-1933	ERIK HUTTEMANN et al.	106/700
*	E	US-2,699,097	01-1955	BINKLEY MARK E	162/153
*	F	US-3,231,657	01-1966	KALOUSEK GEORGE L	264/333
*	G	US-4,523,955	06-1985	Helser, Jerry L.	106/797
*	H	US-4,477,397	10-1984	Helser, Jerry L.	264/37.29
*	I	US-5,330,573	07-1994	Nakano et al.	106/796
*	J	US-3,501,324	03-1970	KUBO KAZUHIKO	106/796
*	K	US-4,388,257	06-1983	Oguri et al.	264/82
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	DE 3641823 (Stellmach) 6/16/88 abstract only.				
	V	JP 59045953 (Asahi Chemical) 3/15/84 abstract only.				
	W	JP 2004051379 (Takahashi et al.) 2/19/2004 abstract only.				
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.